

Notice of References Cited	Application/Control No. 09/558,645		Applicant(s)/Patent Under Reexamination KAPLAN ET AL	
	Examiner Lynne Edmondson		Art Unit 1725	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,677,083	10-1997	Tomiyama, Hideki	429/231.3
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*	D	US-6,187,475	02-2001	Oh et al.	429/205
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	P					
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	R					
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NON-PATENT DOCUMENTS

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	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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